



PJD15N06L

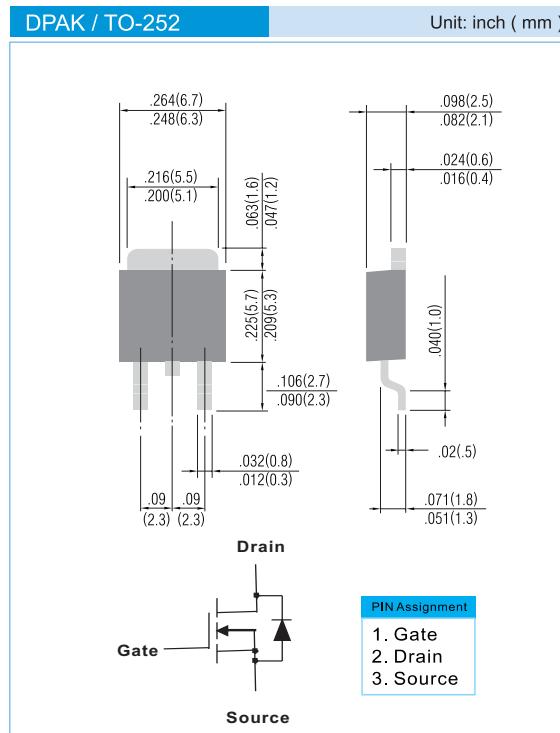
60V N-Channel Enhancement Mode MOSFET

FEATURES

- $R_{DS(ON)}$, $V_{GS} @ 10V, I_{DS} @ 10A = 40m\Omega$
- $R_{DS(ON)}$, $V_{GS} @ 4.5V, I_{DS} @ 8.0A = 50m\Omega$
- Advanced Trench Process Technology
- High Density Cell Design For Ultra Low On-Resistance
- Specially Designed for DC/DC Converters
- Fully Characterized Avalanche Voltage and Current
- Pb free product : 99% Sn above can meet RoHS environment substance directive request

MECHANICAL DATA

- Case: TO-252 Molded Plastic
- Terminals : Solderable per MIL-STD-750D, Method 1036.3
- Marking : 15N06L



Maximum RATINGS and Thermal Characteristics ($T_A=25^\circ C$ unless otherwise noted)

PARAMETER	Symbol	Limit	Units
Drain-Source Voltage	V_{DS}	60	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current	I_D	15	A
Pulsed Drain Current ¹⁾	I_{DM}	60	A
Maximum Power Dissipation	$T_A=25^\circ C$ $T_A=75^\circ C$	P_D 38 22	W
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 to + 150	$^\circ C$
Avalanche Energy with Single Pulse ID=21A, VDD=30V, L=0.5mH	E_{AS}	120	mJ
Junction-to-Case Thermal Resistance	$R_{\theta JC}$	3.3	$^\circ C/W$
Junction-to Ambient Thermal Resistance(PCB mounted) ²	$R_{\theta JA}$	50	$^\circ C/W$

Note: 1. Maximum DC current limited by the package
2. Surface mounted on FR4 board, $t \leq 10$ sec

PAN JIT RESERVES THE RIGHT TO IMPROVE PRODUCT DESIGN, FUNCTIONS AND RELIABILITY WITHOUT NOTICE

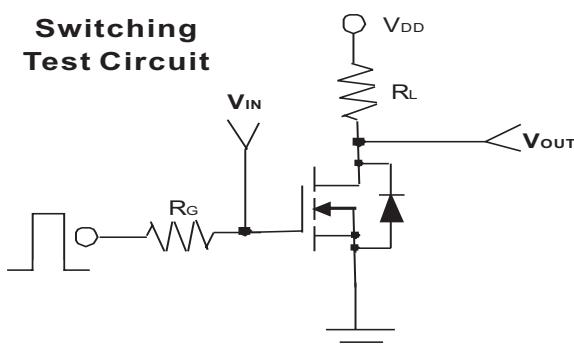


PJD15N06L

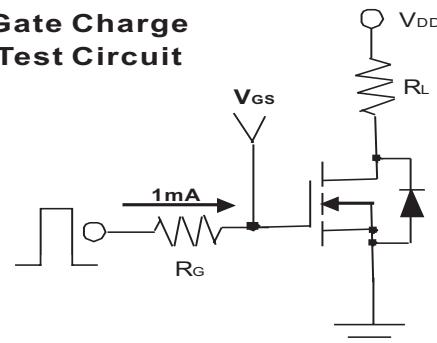
ELECTRICAL CHARACTERISTICS

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Units
Static						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	60	-	-	V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	1	-	3	V
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS}=4.5V, I_D=8.0A$	-	36	50	$m\Omega$
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS}=10V, I_D=10A$	-	32	40	
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=60V, V_{GS}=0V$	-	-	1	μA
Gate Body Leakage	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	± 100	nA
Forward Transconductance	g_{fs}	$V_{DS}=10V, I_D=10A$	20	-	-	S
Dynamic						
Total Gate Charge	Q_g	$V_{DS}=30V, I_D=10A, V_{GS}=5V$	-	17.20	-	nC
Gate-Source Charge	Q_{gs}	$V_{DS}=30V, I_D=10A$ $V_{GS}=10V$	-	32.5	-	
Gate-Drain Charge	Q_{gd}	$V_{DS}=30V, I_D=10A$ $V_{GS}=10V$	-	3.6	-	
Turn-On Delay Time	$T_{d(on)}$	$V_{DD}=30V, R_L=30\Omega$ $I_D=1A, V_{GEN}=10V$ $R_G=3.6\Omega$	-	5.4	-	
Turn-On Rise Time	t_{rr}	$V_{DD}=30V, R_L=30\Omega$ $I_D=1A, V_{GEN}=10V$ $R_G=3.6\Omega$	-	13.2	16.5	ns
Turn-Off Delay Time	$t_{d(off)}$		-	5.8	7.6	
Turn-Off Fall Time	t_f		-	42	55	
Input Capacitance	C_{iss}		-	6.2	7.8	
Output Capacitance	C_{oss}	$V_{DS}=25V, V_{GS}=0V$ $f=1.0MHz$	-	1750	-	pF
Reverse Transfer Capacitance	C_{rss}	$V_{DS}=25V, V_{GS}=0V$ $f=1.0MHz$	-	130	-	
Source-Drain Diode						
Max. Diode Forward Current	I_s	-	-	-	10	A
Diode Forward Voltage	V_{SD}	$I_s=10A, V_{GS}=0V$	-	0.9	1.2	V

Switching Test Circuit



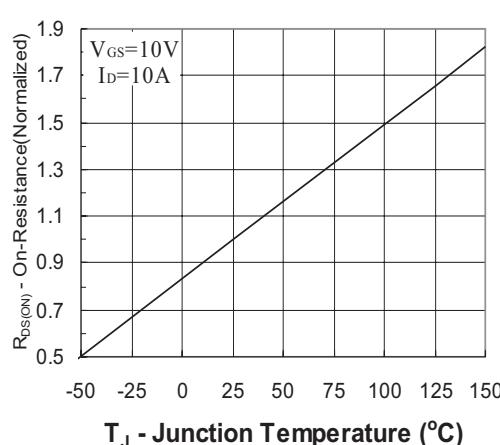
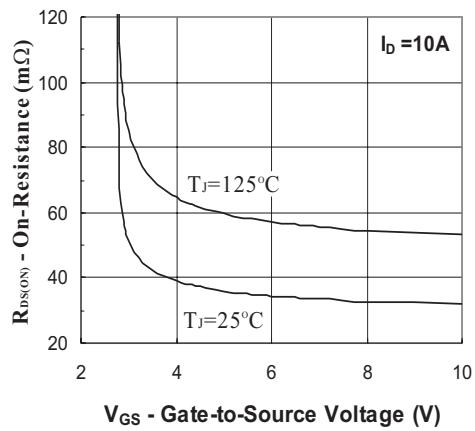
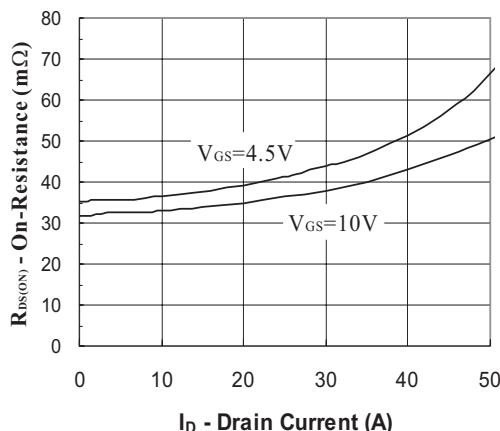
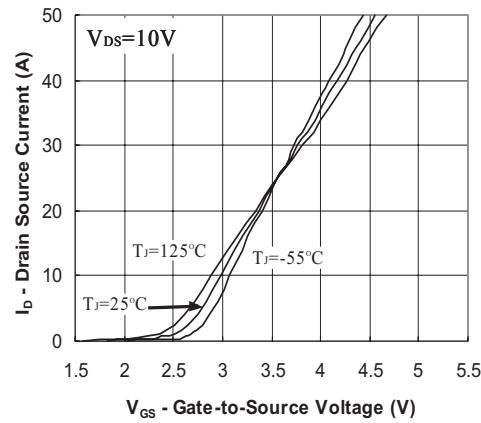
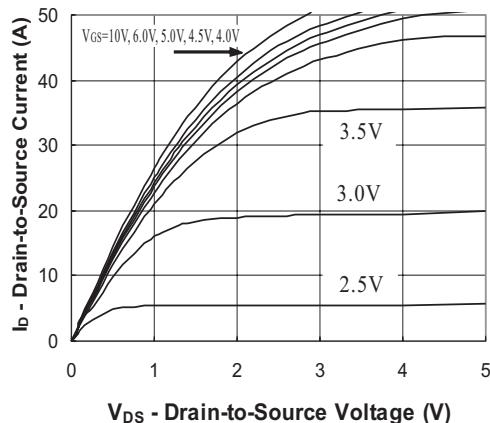
Gate Charge Test Circuit





PJD15N06L

Typical Characteristics Curves ($T_a=25^\circ\text{C}$, unless otherwise noted)





PJD15N06L

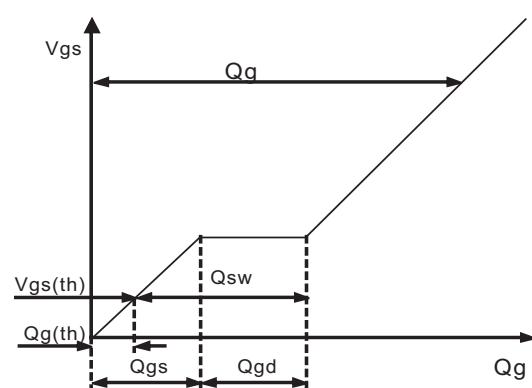


Fig.6 - Gate Charge Waveform

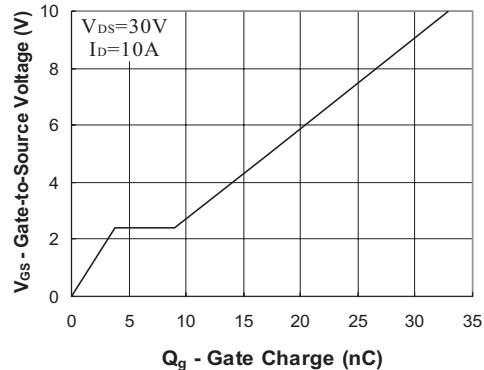


Fig.7 - Gate Charge

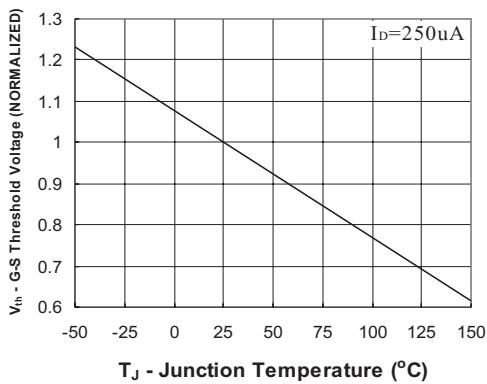


Fig.8 - Threshold Voltage vs Temperature

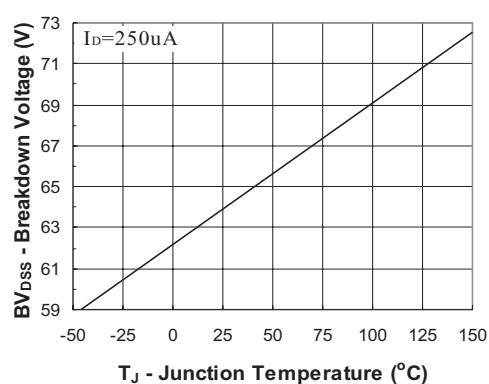


Fig.9 - Breakdown Voltage vs Junction Temperature

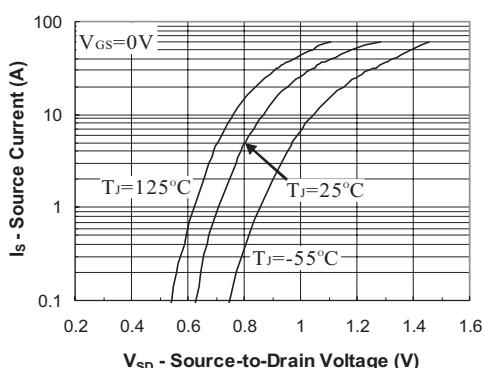


Fig.10 - Source-Drain Diode Forward Voltage

LEGAL STATEMENT

Copyright PanJit International, Inc 2006

The information presented in this document is believed to be accurate and reliable. The specifications and information herein are subject to change without notice. Pan Jit makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose. Pan Jit products are not authorized for use in life support devices or systems. Pan Jit does not convey any license under its patent rights or rights of others.